

24X **b** 

Ф

0.10

0.05

CAB

C NOTE 3

**DATE 17 APR 2012** 

## NOTES:

- DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.
- 2. CONTROLLING DIMENSION: MILLIMETERS.
- DIMENSION b APPLIES TO PLATED TERMINAL
   AND IS MEASURED BETWEEN 0.15 AND 0.30 MM
   FROM TERMINAL TIP.
- COPLANARITY APPLIES TO THE EXPOSED PAD AS WELL AS THE TERMINALS.

	MILLIMETERS	
DIM	MIN	MAX
Α	0.70	0.80
A1	0.00	0.05
А3	0.20 REF	
b	0.20	0.30
D	4.00 BSC	
D2	2.00	2.20
E	4.00 BSC	
E2	2.00	2.20
е	0.50 BSC	
K	0.20	
L	0.30	0.50
L1	0.00	0.15

## GENERIC MARKING DIAGRAM\*



XXXXX = Specific Device Code

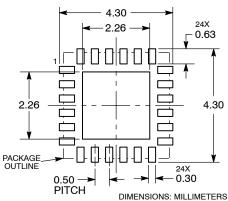
A = Assembly Location

L = Wafer Lot Y = Year W = Work Week ■ Pb-Free Package

(Note: Microdot may be in either location)

\*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G", may or not be present.

## **MOUNTING FOOTPRINT**



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DESCRIPTION:	WQFN24 4X4, 0.5P		PAGE 1 OF 1

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**BOTTOM VIEW** 

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